



CSD88537ND 双路 60V N 通道 NexFET™ 功率金属氧化物半导体场效应晶体管 (MOSFET)

1 特性

- 超低 Q_g 和 Q_{gd}
- 雪崩额定值
- 无铅
- 符合 RoHS 环保标准
- 无卤素

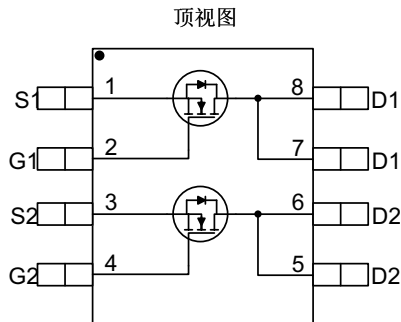
2 应用范围

- 用于电机控制的半桥
- 同步降压转换器

3 说明

这款双路小外形尺寸 (SO)-8, 60V, 12.5mΩ

NexFET™ 功率 MOSFET 旨在用作低电流电机控制应用中的半桥。



产品概要

$T_A = 25^\circ\text{C}$		典型值		单位
V_{DS}	漏源电压	60		V
Q_g	栅极电荷总量 (10V)	14		nC
Q_{gd}	栅漏栅极电荷	2.3		nC
$R_{DS(on)}$	漏源导通电阻	$V_{GS} = 6V$	15	mΩ
		$V_{GS} = 10V$	12.5	mΩ
$V_{GS(th)}$	阈值电压	3.0		V

订购信息⁽¹⁾

器件	介质	数量	封装	出货
CSD88537ND	13 英寸卷带	2500	SO-8 塑料封装	卷带封装
CSD88537NDT	7 英寸卷带	250		

(1) 要了解所有可用封装, 请见数据表末尾的可订购产品附录。

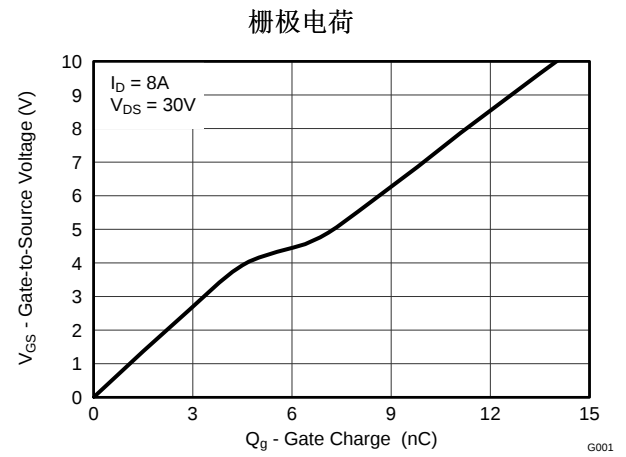
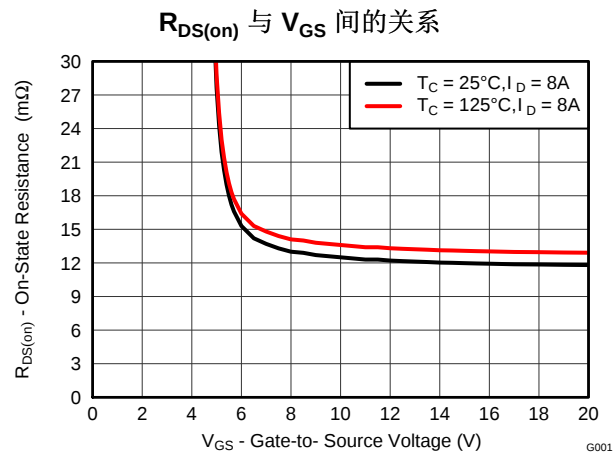
最大绝对额定值

$T_A = 25^\circ\text{C}$		值	单位
V_{DS}	漏源电压	60	V
V_{GS}	栅源电压	± 20	V
I_D	持续漏极电流 (受封装限制)	15	A
	持续漏极电流 (受芯片限制), $T_C = 25^\circ\text{C}$ 时测得	16	
	持续漏极电流 ⁽¹⁾	8.0	
I_{DM}	脉冲漏极电流, $T_A = 25^\circ\text{C}$ 时测得 ⁽²⁾	108	A
P_D	功率耗散 ⁽¹⁾	2.1	W
T_J, T_{stg}	运行结温和储存温度范围	-55 至 150	$^\circ\text{C}$
E_{AS}	雪崩能量, 单脉冲 $I_D = 32, L = 0.1\text{mH}, R_G = 25\Omega$	51	mJ

(1) $R_{\theta JA} = 60^\circ\text{C/W}$, 这是在一个厚度 0.06 英寸环氧树脂 (FR4) 印刷电路板 (PCB) 上的 1 英寸², 2 盎司的铜焊盘上测得的典型值。

(2) 最大 $R_{\theta JL} = 20^\circ\text{C/W}$, 脉冲持续时间 $\leq 100\mu\text{s}$, 占空比 $\leq 1\%$





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4 修订历史记录

Changes from Original (January 2014) to Revision A	Page
• 已将脉冲漏极电流从 62A 增加为 108A	1
• 更新了脉冲漏极电流条件	1
• Changed $R_{\theta JC}$ to $R_{\theta JL}$ in <i>Thermal Information</i>	4
• Updated the SOA in Figure 10	7

5 Specifications

5.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CHARACTERISTICS						
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _D = 250 μA	60			V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 48 V			1	μA
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.6	3	3.6	V
R _{DS(on)}	Drain-to-Source On-Resistance	V _{GS} = 6 V, I _D = 8 A		15	19	mΩ
		V _{GS} = 10 V, I _D = 8 A		12.5	15	mΩ
g _{fs}	Transconductance	V _{DS} = 30 V, I _D = 8 A		42		S
DYNAMIC CHARACTERISTICS						
C _{iss}	Input Capacitance	V _{GS} = 0 V, V _{DS} = 30 V, f = 1 MHz		1080	1400	pF
C _{oss}	Output Capacitance			133	173	pF
C _{rss}	Reverse Transfer Capacitance			4	5.2	pF
R _G	Series Gate Resistance			5.5	11	Ω
Q _g	Gate Charge Total (10 V)	V _{DS} = 30 V, I _D = 8 A		14	18	nC
Q _{gd}	Gate Charge Gate-to-Drain			2.3		nC
Q _{gs}	Gate Charge Gate-to-Source			4.6		nC
Q _{g(th)}	Gate Charge at V _{th}			3.4		nC
Q _{oss}	Output Charge	V _{DS} = 30 V, V _{GS} = 0 V		25		nC
t _{d(on)}	Turn On Delay Time	V _{DS} = 30 V, V _{GS} = 10 V, I _{DS} = 8 A, R _G = 0 Ω		6		ns
t _r	Rise Time			15		ns
t _{d(off)}	Turn Off Delay Time			5		ns
t _f	Fall Time			19		ns
DIODE CHARACTERISTICS						
V _{SD}	Diode Forward Voltage	I _{SD} = 8 A, V _{GS} = 0 V		0.8	1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 30 V, I _F = 8 A, di/dt = 300 A/μs		50		nC
t _{rr}	Reverse Recovery Time			30		ns

5.2 Thermal Information

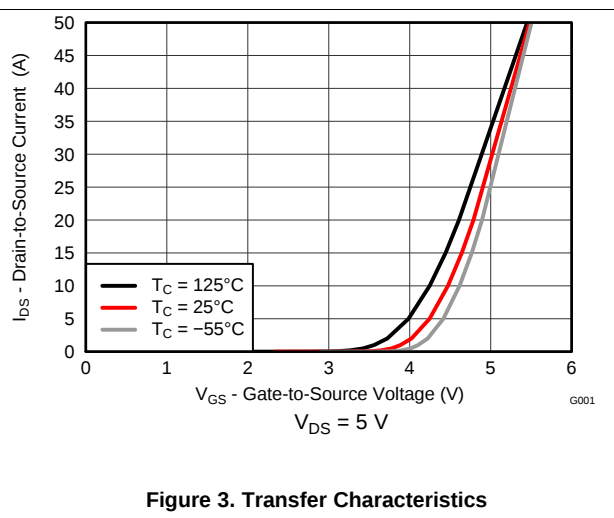
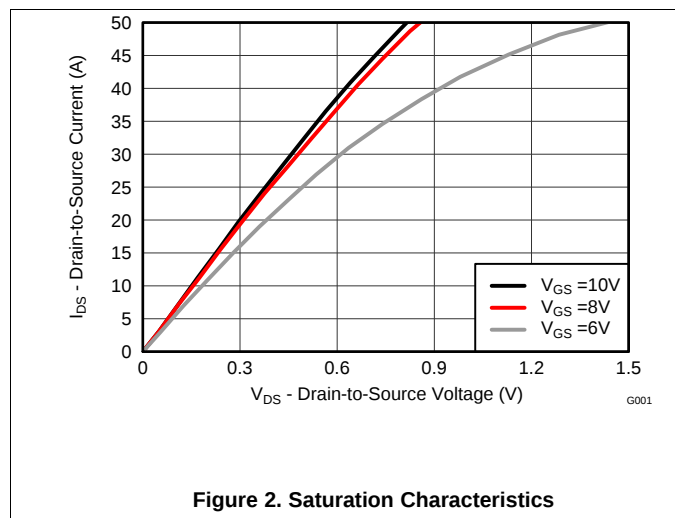
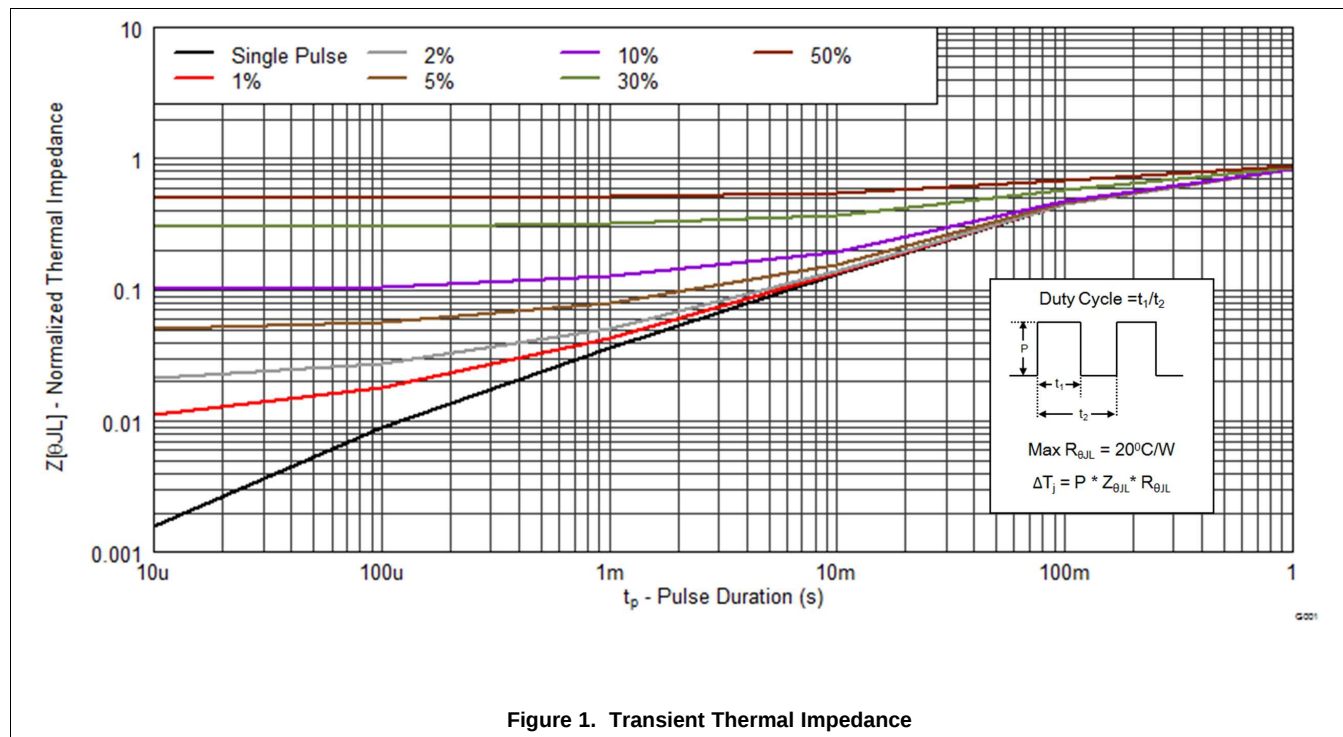
(T_A = 25°C unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
R _{θJL}	Junction-to-Lead Thermal Resistance ⁽¹⁾			20	°C/W
R _{θJA}	Junction-to-Ambient Thermal Resistance ⁽¹⁾⁽²⁾			75	

- (1) R_{θJL} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inches × 1.5-inches (3.81-cm × 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJL} is specified by design, whereas R_{θJA} is determined by the user's board design.
- (2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.

5.3 Typical MOSFET Characteristics

($T_A = 25^\circ\text{C}$ unless otherwise stated)



Typical MOSFET Characteristics (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

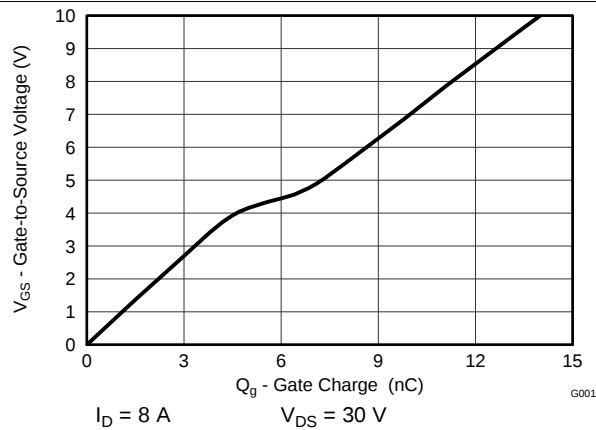


Figure 4. Gate Charge

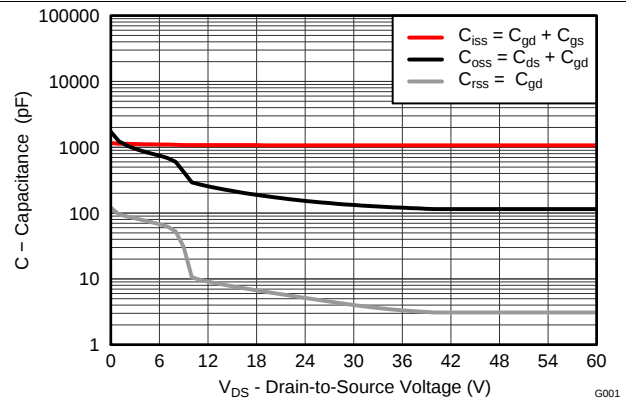


Figure 5. Capacitance

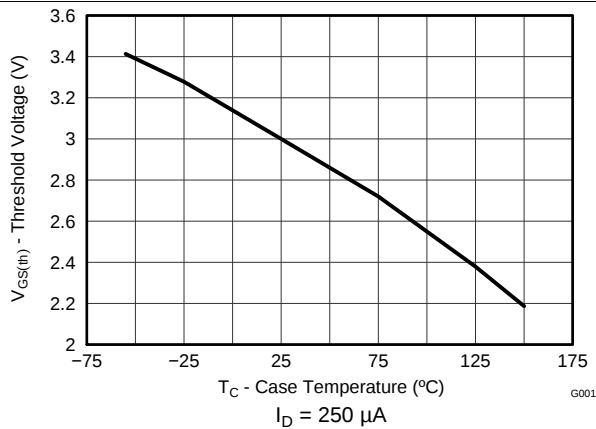


Figure 6. Threshold Voltage vs Temperature

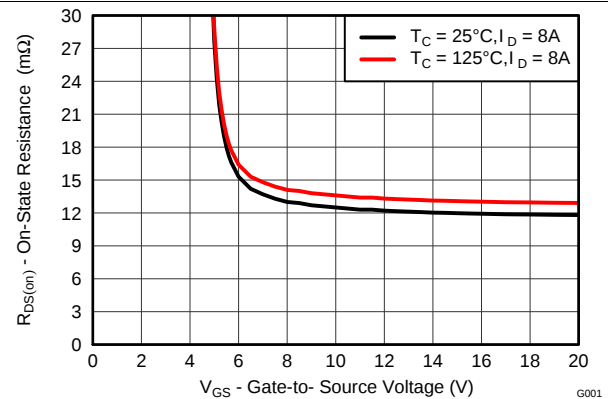


Figure 7. On-State Resistance vs Gate-to-Source Voltage

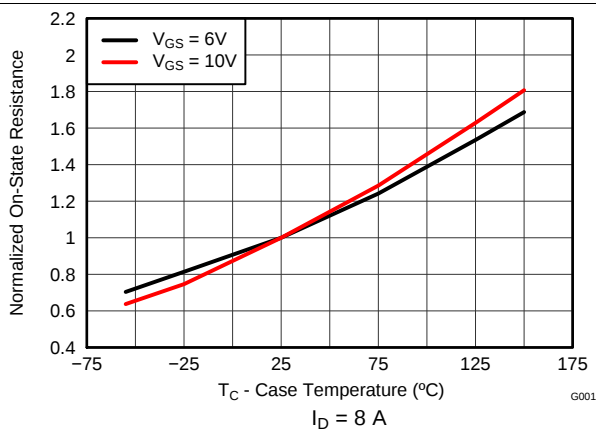


Figure 8. Normalized On-State Resistance vs Temperature

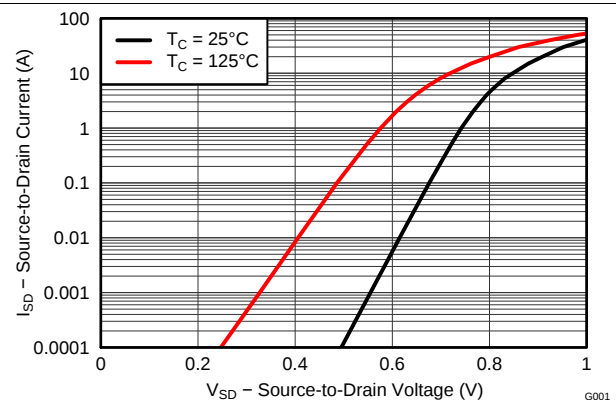


Figure 9. Typical Diode Forward Voltage

Typical MOSFET Characteristics (continued)

($T_A = 25^\circ\text{C}$ unless otherwise stated)

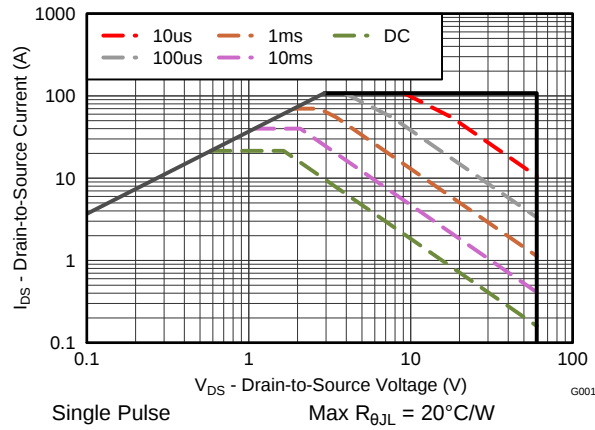


Figure 10. Maximum Safe Operating Area

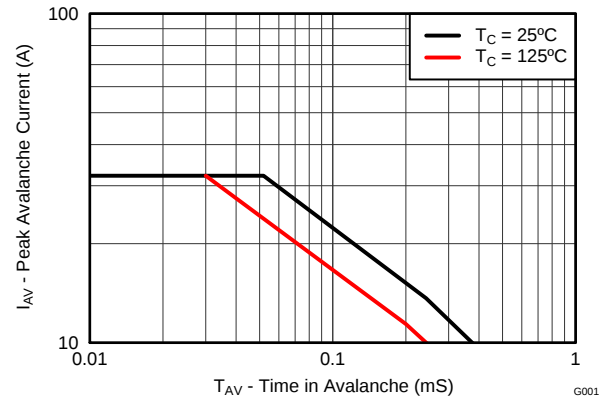


Figure 11. Single Pulse Unclamped Inductive Switching

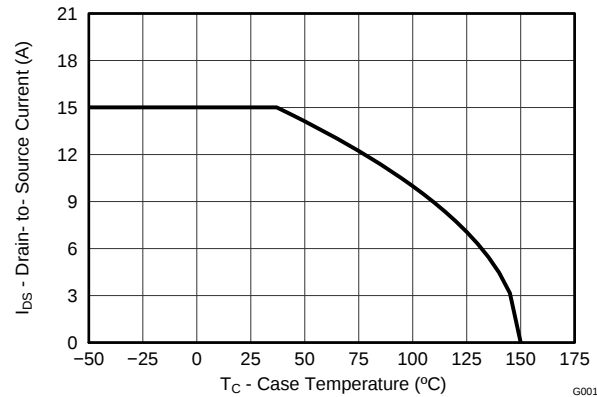


Figure 12. Maximum Drain Current vs Temperature

6 器件和文档支持

6.1 商标

NexFET is a trademark of Texas Instruments.

6.2 静电放电警告



这些装置包含有限的内置 ESD 保护。存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

6.3 术语表

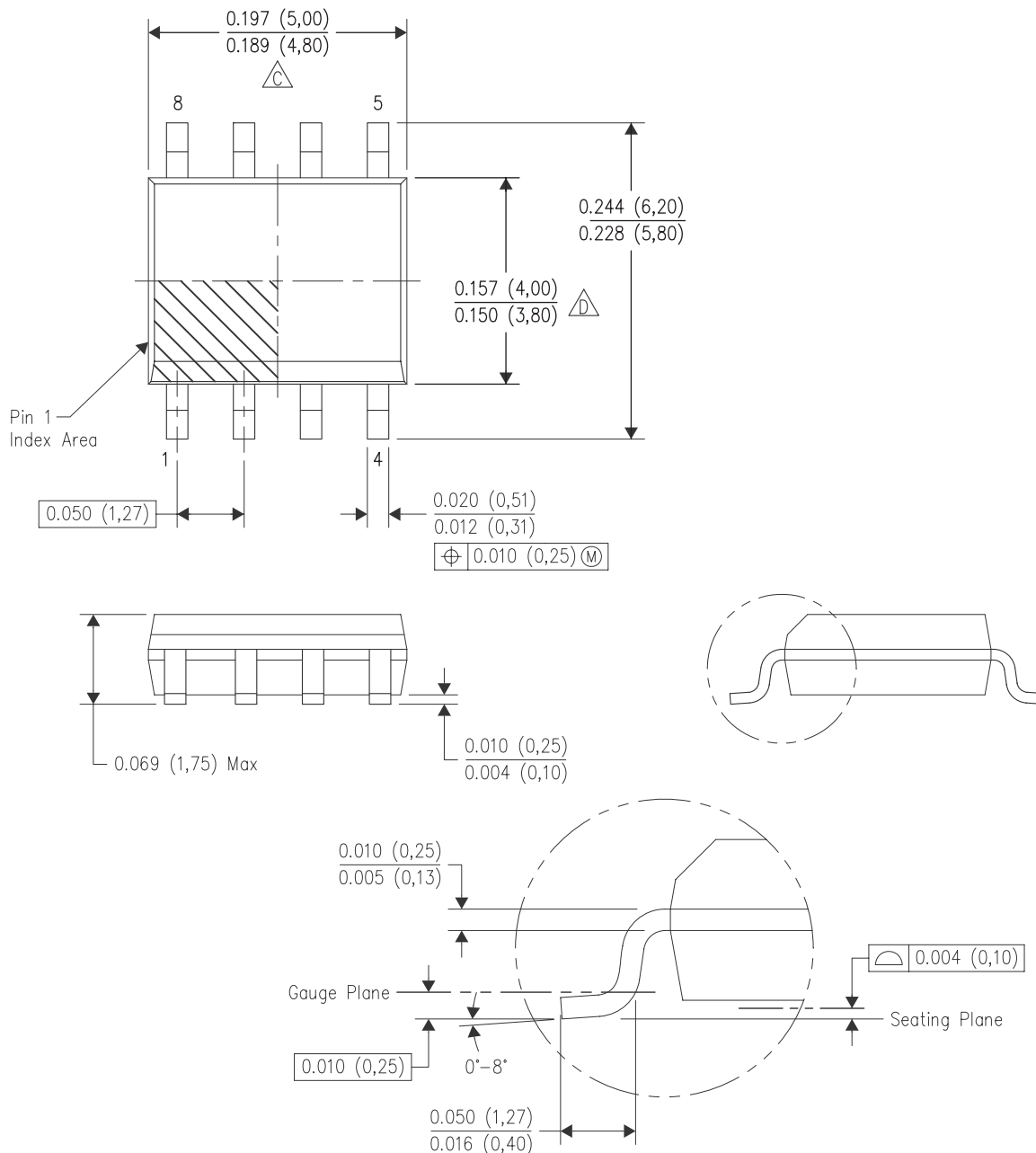
[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

7 机械封装和可订购信息

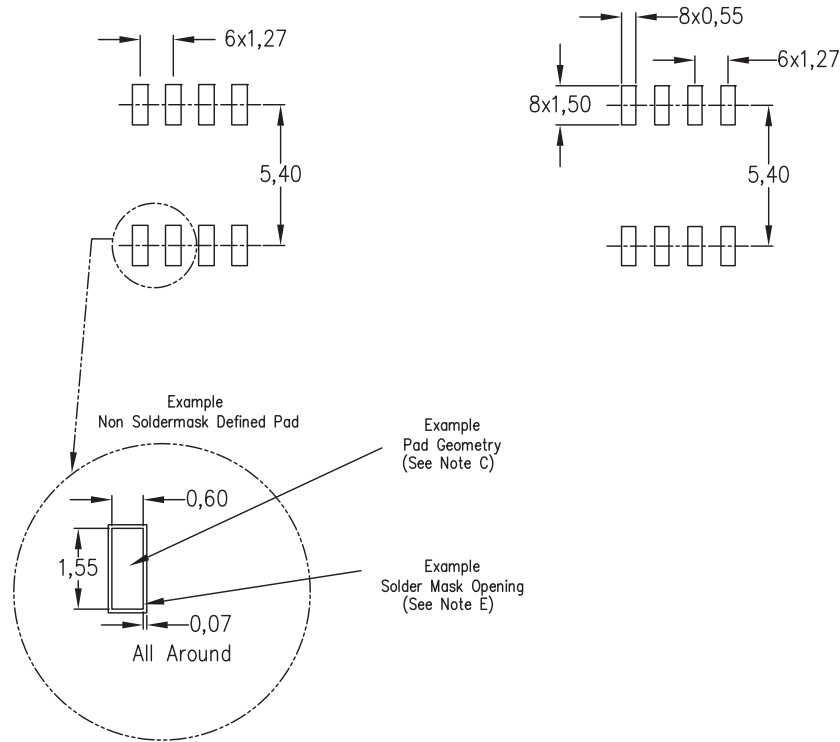
以下页中包括机械封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本，请查阅左侧的导航栏。

7.1 SO-8 封装尺寸



1. 所有线性尺寸的单位均为英寸（毫米）。
2. 本图纸如有变更，恕不通知。
3. 主体长度不包括模具毛边、突出或料口毛刺。 每侧的模具毛边、突出或料口毛刺不得超过 0.006 英寸（0.15 毫米）。
4. 主体宽度不包括引脚间的毛边。 每侧的引脚间毛边不得超过 0.017 英寸（0.43 毫米）。
5. 参考 JEDEC MS-012 变体 AA。

7.2 建议的 PCB 模板布局和开口



1. 所有线性尺寸的单位是毫米。
2. 本图纸如有变更，恕不通知。
3. 建议在替代设计中采用公布的 **IPC-7351** 标准。
4. 具有漏斗形壁和圆角的激光切割窗孔将提供最佳的焊锡膏脱离。 客户应联系其电路板组装站点获取漏网印板设计建议。 关于其他模板建议，请参见 **IPC-7525**。
5. 客户应联系其电路板生产厂获取有关信号盘之间以及信号盘周围的阻焊层容差的信息。

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD88537ND	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	88537N
CSD88537NDG4	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	88537N
CSD88537NDG4.B	Active	Production	SOIC (D) 8	2500 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	88537N
CSD88537NDT	Active	Production	SOIC (D) 8	250 SMALL T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 150	88537N

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

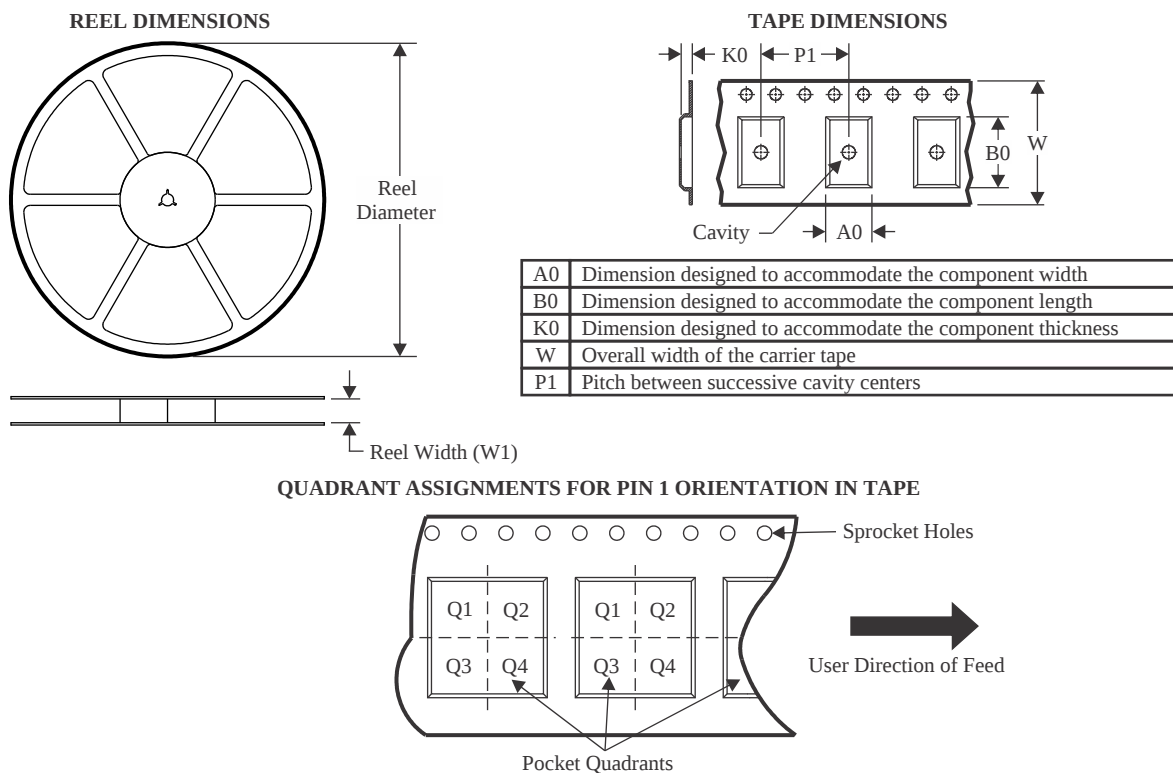
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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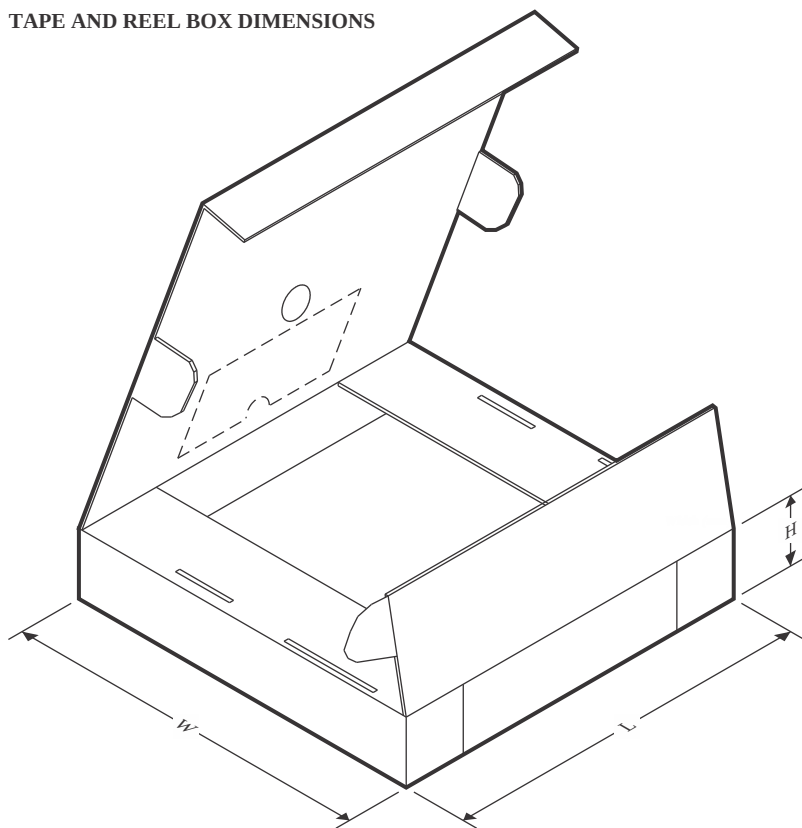
TAPE AND REEL INFORMATION



*All dimensions are nominal

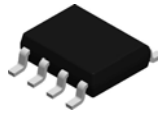
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CSD88537NDT	SOIC	D	8	250	178.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CSD88537NDT	SOIC	D	8	250	180.0	180.0	79.0

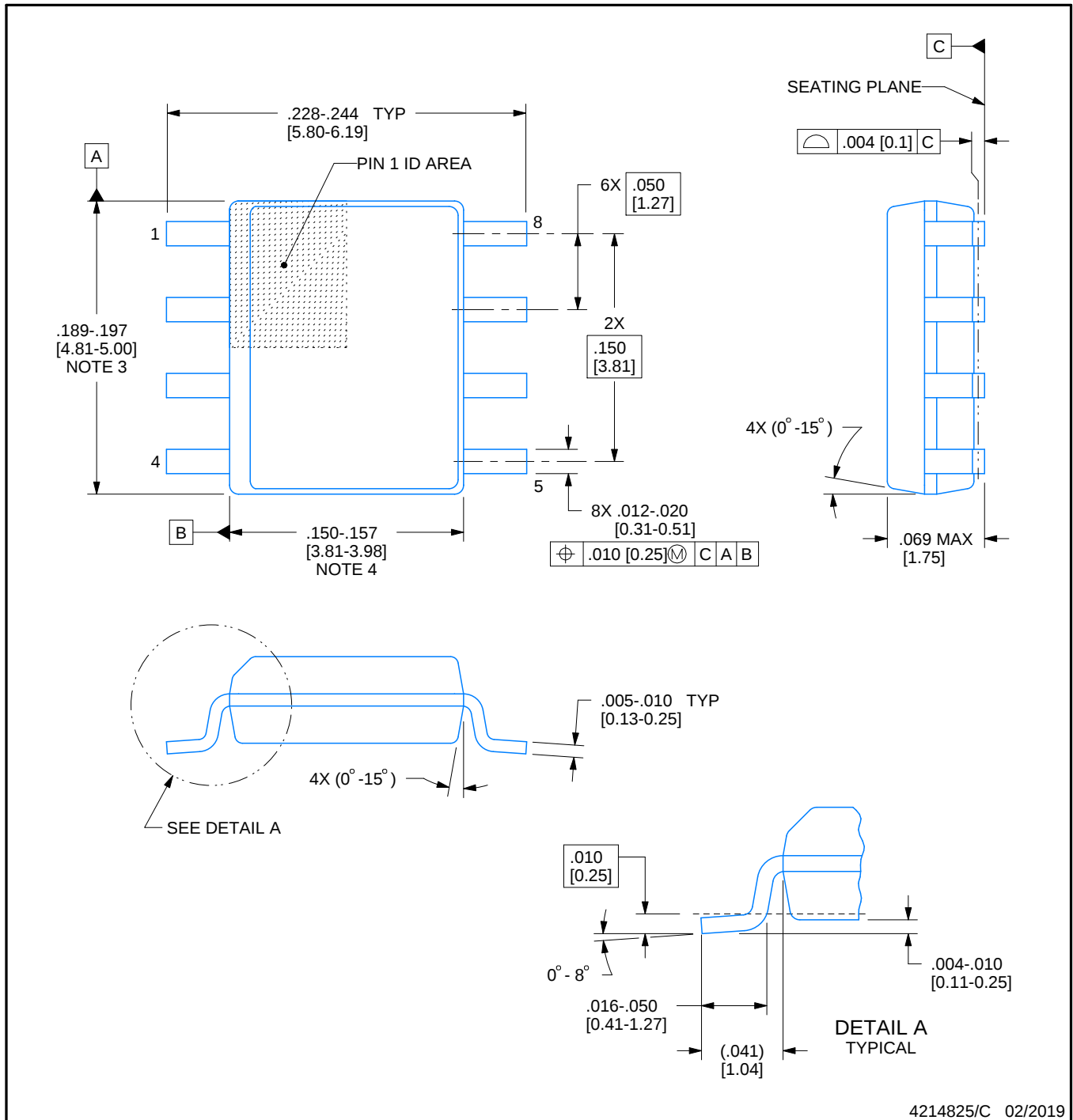


D0008A

PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

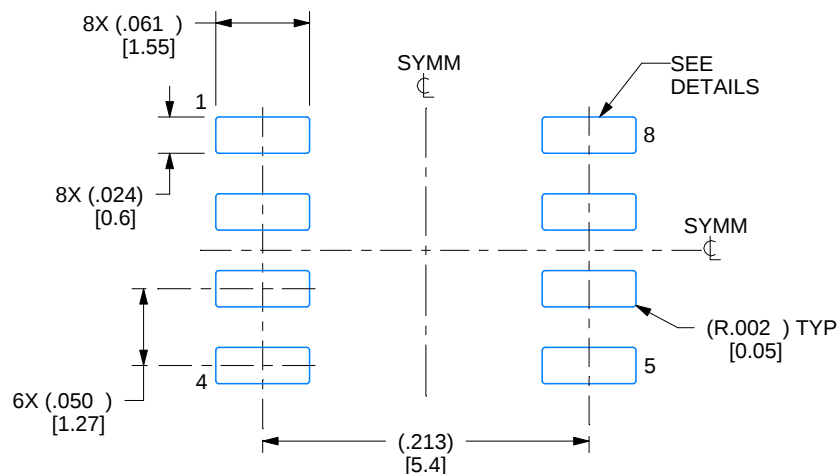
1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

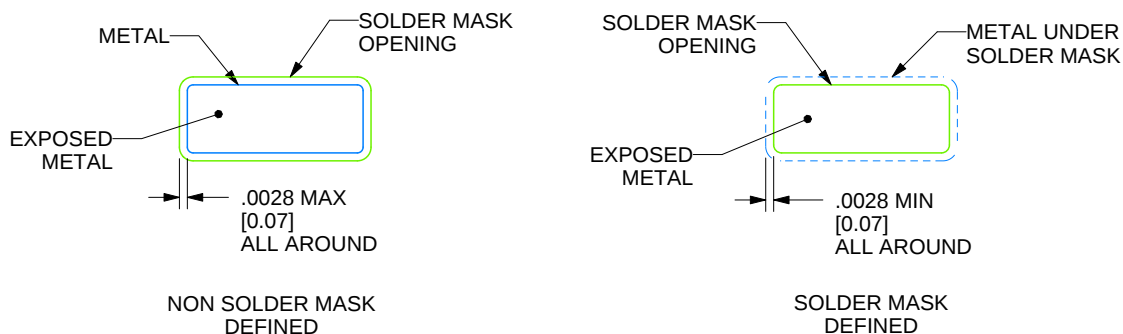
D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

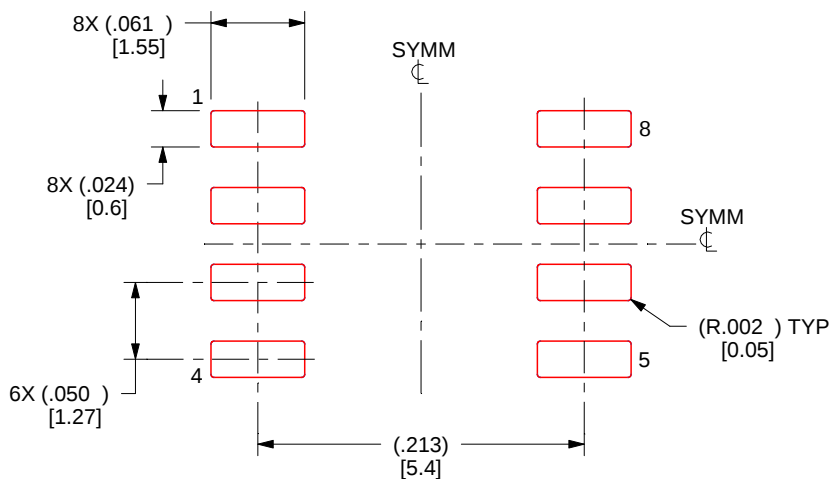
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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